# STK-IN4300 Statistical Learning Methods in Data Science

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#### Outline of the lecture

- Linear Methods for Regression
  - Linear Regression Models and Least Squares
  - Subset selection
- Model Assessment and Selection
  - Bias, Variance and Model Complexity
  - The Bias-Variance Decomposition
  - Optimism of the Training Error Rate
  - Estimates of In-Sample Prediction Error
  - The Effective Number of Parameters
  - The Bayesian Approach and BIC

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### Linear Regression Models and Least Squares: recap

### Consider:

- continuous outcome Y, with  $Y = f(X) + \epsilon$ ;
- linear regression  $f(X) = \beta_0 + \beta_1 X_1 + \cdots + \beta_p X_p$

### We know:

$$\quad \hat{\beta} = \mathrm{argmin}_{\beta} RSS(\beta) = (X^TX)^{-1}X^Ty;$$

• 
$$\hat{y} = X\hat{\beta} = \underbrace{X(X^TX)^{-1}X^T}_{\text{hat matrix H}} y;$$

• 
$$Var(\hat{\beta}) = (X^T X)^{-1} \sigma^2$$
  
•  $\hat{\sigma}^2 = \frac{1}{N-n-1} \sum_{i=1}^{N} (y_i - \hat{y}_i)^2$ ;

When  $\epsilon \sim N(0, \sigma^2)$ ,

- $\hat{\beta} \sim N(\beta, (X^T X)^{-1} \sigma^2);$
- $(N-p-1)\hat{\sigma}^2 \sim \sigma^2 \chi_{N-p-1}^2$ .

### Linear Regression Models and Least Squares: Gauss – Markov theorem

The least square estimator  $\hat{\theta} = a^T (X^T X)^{-1} X^T y$  is the

 $\mathbf{B}$  est  $\leftarrow$  smallest error (MSE)

**L** inear 
$$\leftarrow \hat{\theta} = a^T \beta$$

**U** nbiased 
$$\leftarrow E[\hat{\theta}] = \theta$$

**E** stimator

Remember the error decomposition,

$$E[(Y - \hat{f}(X))^2] = \underbrace{\sigma^2}_{\text{irreducible error}} + \underbrace{\operatorname{Var}(\hat{f}(X))}_{\text{variance}} + \underbrace{E[\hat{f}(X) - f(X)]^2}_{\text{bias}^2};$$
 
$$\underbrace{\operatorname{mean square error (MSE)}}$$

then, any estimator  $\tilde{\theta}=c^TY$  , s.t.  $E[c^TY]=a^T\beta$  , has

$$Var(c^TY) \geqslant Var(a^T\hat{\beta})$$

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## Linear Regression Models and Least Squares: hypothesis testing

To test  $H_0: \beta_i = 0$ , we use the Z-score statistic,

$$z_j = \frac{\hat{\beta}_j - 0}{sd(\hat{\beta}_j)} = \frac{\hat{\beta}_j}{\hat{\sigma}\sqrt{(X^T X)_{[j,j]}^{-1}}}$$

• When  $\sigma^2$  is unknown, under  $H_0$ ,

$$z_i \sim t_{N-p-1}$$

where  $t_k$  is a Student t distribution with k degrees of freedom.

• When  $\sigma^2$  is known, under  $H_0$ ,

$$z_j \sim N(0;1).$$

To test  $H_0: \beta_j, \beta_k = 0$ ,

$$F = \frac{(RSS_0 - RSS_1)/(p_1 - p_0)}{RSS_1/(N - p - 1)},$$

where  $_{1}$  and  $_{0}$  refer to the larger and smaller models, respectively.

#### Subset selection: variable selection

## Why choosing a sparser (less variables) model?

- prediction accuracy (smaller variance);
- interpretability (easier to understand the model);
- portability (easier to use in practice).

## Classical approaches:

- forward selection;
- backward elimination;
- stepwise and stepback selection;
- best subset technique.
- stagewise selection.

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## Subset selection: classical approaches

### Forward selection:

- start with the null model,  $Y = \beta_0 + \epsilon$ ;
- among a set of possible variables, add that which reduces the unexplained variability the most
  - e.g.: after the first step,  $Y = \beta_0 + \beta_2 X_2 + \epsilon$ ;
- repeat iteratively until a certain stopping criterion (p-value larger than a threshold  $\alpha$ , increasing AIC, ...) is met.

### **Backward elimination:**

- start with the full model,  $Y = \beta_0 + \beta_1 X_1 + \cdots + \beta_p X_p + \epsilon$ ;
- remove the variable that contributes the least in explaining the outcome variability
  - e.g.: after the first step,  $Y = \beta_0 + \beta_2 X_2 + \cdots + \beta_p X_p + \epsilon$ ;
- repeat iteratively until a stopping criterion (p-value of all remaining variable smaller than  $\alpha$ , increasing AIC, ...) is met.

## Subset selection: classical approaches

## Stepwise and stepback selection:

- mixture of forward and backward selection;
- allow both adding and removing variables at each step;
  - starting from the null model: stepwise selection;
  - starting from the full model: stepback selection.

### Best subset:

- compute all the  $2^p$  possible models (each variable in/out);
- choose the model which minimizes a loss function (e.g., AIC).

## Stagewise selection:

- similar to the forward selection;
- at each step, the specific regression coefficient is updated only using the information related to the corresponding variable;
  - slow to converge in low-dimensions;
  - turned out to be effective in high-dimensional settings.

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#### Model Assessment and Selection: introduction

- **Model Assessment:** evaluate the performance (e.g., in terms of prediction) of a selected model.
- Model Selection: select the best model for the task (e.g., best for prediction).
- **Generalization:** a (prediction) model must be valid in broad generality, not specific for a specific dataset.

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## Bias, Variance and Model Complexity: definitions

### Define:

- Y = target variable;
- X = input matrix;
- $\hat{f}(X) = \text{prediction rule, trained on a training set } \mathcal{T}.$

The error is measured through a loss function

$$L(Y, \hat{f}(X))$$

which penalizes differences between Y and  $\hat{f}(X)$ .

Typical choices for continuous outcomes are:

- $L(Y, \hat{f}(X)) = (Y \hat{f}(X))^2$ , the quadratic loss;
- $L(Y, \hat{f}(X)) = |Y \hat{f}(X)|$ , the absolute loss.

## Bias, Variance and Model Complexity: categorical variables

Similar story for the categorical variables:

•  $G = \text{target variable} \rightarrow \text{takes } K \text{ values in } \mathcal{G};$ 

Typical choices for the loss function in this case are:

- $L(Y, \hat{f}(X)) = \mathbb{1}(G \neq \hat{G}(X))$ , the 0-1 loss;
- $L(Y, \hat{f}(X)) = -2 \log \hat{p}_G(X)$ , the deviance.
- $\log \hat{p}_G(X) = \ell(\hat{f}(X))$  is general and can be use for every kind of outcome (binomial, Gamma, Poisson, log-normal, . . . )
- the factor -2 is added to make the loss function equal to the squared loss in the Gaussian case,

$$L(\hat{f}(X)) = \frac{1}{\sqrt{2\pi 1}} \exp\left\{-\frac{1}{2 \cdot 1} (Y - \hat{f}(X))^2\right\}$$
$$\ell(\hat{f}(X)) = -\frac{1}{2} (Y - \hat{f}(X))^2$$

## Bias, Variance and Model Complexity: test error

The test error (or generalization error) is the prediction error over an independent test sample

$$\mathsf{Err}_{\mathcal{T}} = E[L(Y, \hat{f}(X)) | \mathcal{T}]$$

where both X and Y are drawn randomly from their joint distribution.

The specific training set  $\mathcal{T}$  used to derive the prediction rule is fixed  $\rightarrow$  the test error refers to the error for this specific  $\mathcal{T}$ .

In general, we would like to minimize the expected prediction error (expected test error),

$$\operatorname{Err} = E[L(Y, \hat{f}(X))] = E[\operatorname{Err}_{\mathcal{T}}].$$

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## Bias, Variance and Model Complexity: training error

- We would like to get Err, but we only have information on the single training set (we will see later how to solve this issue);
- our goal, therefore, is to estimate  $Err_{\mathcal{T}}$ .

## The training error

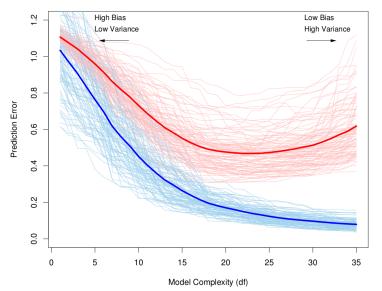
$$\overline{\mathsf{err}} = \frac{1}{N} \sum_{i=1}^{N} L(y_i, \hat{f}(x_i)),$$

is **NOT** a good estimator of  $Err_{\mathcal{T}}$ .

We do not want to minimize the training error:

- increasing the model complexity, we can always decrease it;
- overfitting issues:
  - model specific for the training data;
  - generalize very poorly.

## Bias, Variance and Model Complexity: prediction error



## Bias, Variance and Model Complexity: data split

In an ideal (= a lot of data) situation, the best option is **randomly** splitting the data in three **independent** sets,

training	validation	test
model selection —		model assessment

- training set: data used to fit the model(s);
- validation set: data used to identify the best model;
- **test set:** data used to assess the performance of the best model (must be completely ignored during model selection).

NB: it is extremely important to use the sets fully independently!

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## Bias, Variance and Model Complexity: data split

## Example with k-nearest neighbour:

- in the **training set**: fit kNN with different values of k;
- in the validation set: select the model with best performance (choose k);
- in the **test set:** evaluate the prediction error of the model with the selected k.

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## Bias, Variance and Model Complexity: data split

How to split the data in three set? There is not a general rule.

The book's suggestion:

• training set: 50%;

validation set: 25%;

• test set: 25%.

We will see later what to do when there are no enough data;

• difficult to say when the data are "enough".

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### The Bias-Variance Decomposition: computations

Consider 
$$Y = f(X) + \epsilon$$
,  $E[\epsilon] = 0$ ,  $Var[\epsilon] = \sigma^2$ . Then

$$\begin{aligned} & \mathsf{Err}(x_0) = E[(Y - \hat{f}(X))^2 | X = x_0] \\ & = E[Y^2] + E[\hat{f}(x_0)^2] - 2E[Y\hat{f}(x_0))] \\ & = \mathsf{Var}[Y] + f(x_0)^2 + \mathsf{Var}[\hat{f}(x_0)] + E[\hat{f}(x_0)]^2 - 2f(x_0)E[\hat{f}(x_0)] \\ & = \sigma^2 + \mathsf{bias}^2(\hat{f}(x_0)) + \mathsf{Var}[\hat{f}(x_0)] \\ & = \mathsf{irreducible error} + \mathsf{bias}^2 + \mathsf{variance} \end{aligned}$$

### Remember that:

- $E[Y] = E[f(X) + \epsilon] = E[f(X)] + E[\epsilon] = f(X) + 0 = f(X);$
- $E[Y^2] = Var[Y] + E[Y]^2 = \sigma^2 + f(X)^2$ ;
- $\hat{f}(X)$  and  $\epsilon$  are uncorrelated.

## The Bias-Variance Decomposition: k-nearest neighbours

For the kNN regression:

$$\operatorname{Err}(x_0) = E_Y[(Y - \hat{f}_k(x_0))^2 | X = x_0]$$

$$= \sigma_{\epsilon}^2 + \left[ f(x_0) - \frac{1}{k} \sum_{\ell=1}^k f(x_{\ell}) \right]^2 + \frac{\sigma_{\epsilon}^2}{k}$$

#### Note:

- the number of neighbour is inversely related to the complexity;
- smaller  $k \rightarrow$  smaller bias, larger variance;
- larger  $k \rightarrow$  larger bias, smaller variance.

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### The Bias-Variance Decomposition: linear regression

For linear regression, with a p-dimensional  $\beta$  (regression coefficients) estimated by least squares,

$$\operatorname{Err}(x_0) = E_Y[(Y - \hat{f}_p(x_0))^2 | X = x_0]$$
  
=  $\sigma_{\epsilon}^2 + [f(x_0) - E[f_p(x_0)]]^2 + ||h(x_0)||^2 \sigma_{\epsilon}^2$ 

where  $h(x_0) = X(X^T X)^{-1} x_0$ ,

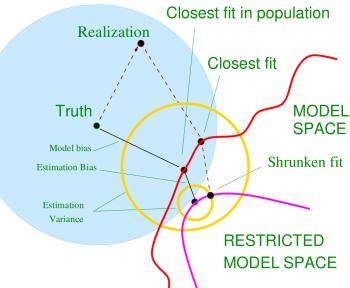
• 
$$\hat{f}_p(x_0) = x_0^T (X^T X)^{-1} X^T y \to \text{Var}[\hat{f}_p(x_0)] = ||h(x_0)||^2 \sigma_{\epsilon}^2$$
.

In average,

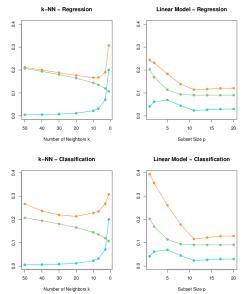
$$\frac{1}{N} \sum_{i=1}^{N} \mathsf{Err}(x_i) = \sigma_{\epsilon}^2 + \frac{1}{N} \sum_{i=1}^{N} [f(x_i) - E[f_p(x_i)]]^2 + \frac{p}{N} \sigma_{\epsilon}^2,$$

so the model complexity is directly related to p.

## The Bias–Variance Decomposition:



## The Bias-Variance Decomposition: example



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## Optimism of the Training Error Rate: definitions

Being a little bit more formal,

$$\mathsf{Err}_{\mathcal{T}} = E_{X_0,Y_0}[L(Y_0,\hat{f}(X_0))|\mathcal{T}]$$

where:

- $(X_0, Y_0)$  are from the new test set;
- $\mathcal{T} = \{(x_1, y_1) \dots (x_n, y_n)\}$  is fixed.

Taking the expected value over  $\mathcal{T}$ , we obtain the expected error

$$\mathsf{Err} = E_{\mathcal{T}} \left[ E_{X_0,Y_0} [L(Y_0,\hat{f}(X_0)) | \mathcal{T}] \right].$$

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### Optimism of the Training Error Rate: definitions

We said that the training error,

$$\overline{\text{err}} = \frac{1}{N} \sum_{i=1}^{N} L(y_i, \hat{f}(x_i)),$$

is **NOT** a good estimator of  $Err_T$ :

- same data used both for training and test;
- a fitting method tends to adapt to the specific dataset;
- the result is a too optimistic evaluation of the error.

How to measure this optimism?

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## Optimism of the Training Error Rate: optimism and average optimism

Let us define the in-sample error,

$$\mathsf{Err}_{\mathsf{in}} = \sum_{i=1}^{N} E_{Y_0}[L(Y_{i0}, \hat{f}(x_i))|\mathcal{T}],$$

i.e., the error computed w.r.t. new values of the outcome on the same values of the training points  $x_i, i = 1, ..., N$ .

We define optimism the difference between Errin and err,

$$op := Err_{in} - \overline{err}$$
.

and the average optimism its expectation,

$$\omega := E_Y[\mathsf{op}].$$

NB: as the training points are fixed, the expected value is taken w.r.t. their outcomes.

## Optimism of the Training Error Rate: optimism and average optimism

For a reasonable number of loss functions, including 0-1 loss and squared error, it can be shown that

$$\omega = \frac{2}{N} \sum_{i=1}^{N} \text{Cov}(\hat{y}_i, y_i),$$

### where:

- Cov stands for covariance;
- $\hat{y}_i$  is the prediction,  $\hat{y}_i = \hat{f}(x_i)$ ;
- $y_i$  is the actual value.

### Therefore:

- optimism depends on how much  $y_i$  affects its own prediction;
- the "harder" we fit the data, the larger the value of  $Cov(\hat{y}_i, y)$   $\rightarrow$  the larger the optimism.

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## Optimism of the Training Error Rate: optimism and average optimism

As a consequence,

$$E_Y[\mathsf{Err}_{\mathsf{in}}] = E_Y[\overline{\mathsf{err}}] + \frac{2}{N} \sum_{i=1}^N \mathsf{Cov}(\hat{y}_i, y_i).$$

When  $\hat{y}_i$  is obtained by a linear fit of d inputs the expression simplifies. For the linear additive model  $Y = f(X) + \epsilon$ ,

$$\sum_{i=1}^{N} \mathsf{Cov}(\hat{y}_i, y_i) = d\sigma_{\epsilon}^2,$$

and

$$E_Y[\mathsf{Err}_{\mathsf{in}}] = E_Y[\overline{\mathsf{err}}] + 2\frac{d}{N}\sigma_\epsilon^2.$$
 (1)

Therefore:

- optimism increases linearly with the number of predictors;
- it decreases linearly with the training sample size.

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## Optimism of the Training Error Rate: estimation

### Methods we will see:

- C<sub>p</sub>, AIC, BIC estimate the optimism and add it to the training error (work when estimates are linear in their parameters);
- cross-validation and bootstrap directly estimate the expected error (work in general).

### Further notes:

- in-sample error is in general NOT of interest;
- when doing model selection/find the right model complexity, we are more interested in the relative difference in error rather than the absolute one.

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## Estimates of In-Sample Prediction Error: $C_p$

Consider the general form of the in-sample estimates,

$$\widehat{\mathsf{Err}}_{\mathsf{in}} = \overline{\mathsf{err}} + \hat{\omega}.$$

Equation (1),

$$E_Y[\mathsf{Err}_\mathsf{in}] = E_Y[\overline{\mathsf{err}}] + 2\frac{d}{N}\sigma_\epsilon^2,$$

in the case of linearity and square errors, leads to the  $C_p$  statistics,

$$\mathsf{C}_p = \overline{\mathsf{err}} + 2\frac{d}{N}\hat{\sigma}_{\epsilon}^2,$$

#### where:

- err is the training error computed by the square loss;
- *d* is the number of parameters (e.g., regression coefficients);
- $\hat{\sigma}_{\epsilon}^2$  is an estimate of the noise variance (computed on the full model, i.e., that having the smallest bias).

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### Estimates of In-Sample Prediction Error: AIC

## Similar idea for AIC (Akaike Information Criterion):

- we start from equation (1);
- more general by using a log-likelihood approach,

$$-2E[\log p_{\hat{\theta}}(Y)] \approx -\frac{2}{N}E\left[\sum_{i=1}^{N}\log p_{\hat{\theta}}(y_i)\right] + 2\frac{d}{N}$$

#### Note that:

- the result holds asymptotically (i.e.,  $N \to \infty$ );
- $p_{\hat{\theta}}(Y)$  is the family of densities of Y, indexed by  $\theta$ ;
- $\sum_{i=1}^{N} \log p_{\hat{\theta}}(y_i) = \ell(\hat{\theta})$ , the maximum likelihood estimate.

## Examples:

- logistic regression, AIC =  $-\frac{2}{N}\ell(\hat{\theta}) + 2\frac{d}{N}$ ;
- linear regression, AIC  $\propto C_n$ .

### Estimates of In-Sample Prediction Error: AIC

To find the best model, we choose that with the smallest AIC:

- straightforward in the simplest cases (e.g., linear models);
- more attention must be devoted in more complex situations
  - issue of finding a reasonable measure for the model complexity;

Usually minimizing the AIC is not the best solution to find the value of the tuning parameter

cross-validation works better in this case.

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#### The Effective Number of Parameters

Generalize the concept of number of predictors to extend the previous approaches to more complex situations.

Let

- $y = (y_1, \dots, y_n)$  be the outcome;
- $\hat{y} = (\hat{y}_1, \dots, \hat{y}_n)$  be the prediction.

For linear methods,

$$\hat{y} = Sy$$

where S is a  $N \times N$  matrix which

- $\bullet$  depend on X
- does NOT depend on y.

#### The Effective Number of Parameters

The effective number of parameters (or effective degrees of freedom) is defined as

$$df(S) := trace(S);$$

- trace(S) is the sum of the diagonal elements of S;
- we should replace d with trace(S) to obtain the correct value of the criteria seen before;
- if  $y = f(X) + \epsilon$ , with  $\text{Var}(\epsilon) = \sigma_{\epsilon}^2$ , then  $\sum_{i=1}^N \text{Cov}(\hat{y}_i, y_i) = \text{trace}(S)\sigma_{\epsilon}^2$ , which motivates

$$\mathsf{df}(\hat{y}) = \frac{\sum_{i=1}^{N} \mathsf{Cov}(\hat{y}_i, y_i)}{\sigma_{\epsilon}^2}.$$

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### The Bayesian Approach and BIC: BIC

The BIC (Bayesian Information Criterion) is an alternative criterion to AIC,

$$\frac{1}{N}\mathsf{BIC} = -\frac{2}{N}\ell(\hat{\theta}) + \log N\frac{d}{N}$$

- similar to AIC, with log N instead of 2;
- if  $N > e^2 \approx 7.4$ , BIC tends to favor simpler models than AIC.
- For the Gaussian model,

$$\mathsf{BIC} = \frac{N}{\sigma_\epsilon^2} \left[ \overline{\mathsf{err}} + (\log N) \frac{d}{N} \sigma_\epsilon^2 \right].$$

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## The Bayesian Approach and BIC: motivations

Despite similarities, AIC and BIC come from different ideas. In particular, BIC comes form the Bayesian model selection approach. Suppose

- $\mathcal{M}_m$ ,  $m = 1, \dots, M$  be a set of candidate models;
- $\theta_m$  be their correspondent parameters;
- $Z = (x_1, y_1), \dots, (x_N, y_N)$  be the training data.

Given the prior distribution  $Pr(\theta_m|\mathcal{M}_m)$  for all  $\theta_m$ , the posterior is

$$Pr(\mathcal{M}_m|z) \propto Pr(\mathcal{M}_m) \cdot Pr(Z|\mathcal{M}_m)$$

$$\propto Pr(\mathcal{M}_m) \cdot \int_{\Theta_m} Pr(Z|\mathcal{M}_m, \theta_m) \cdot Pr(\theta_m|\mathcal{M}_m) \ d\theta_m.$$

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## The Bayesian Approach and BIC: motivations

To choose between two models, we compare their posterior distributions,

$$\frac{Pr(\mathcal{M}_m|z)}{Pr(\mathcal{M}_\ell|z)} = \underbrace{\frac{Pr(\mathcal{M}_m)}{Pr(\mathcal{M}_\ell)}}_{\text{prior preference}} \cdot \underbrace{\frac{Pr(Z|\mathcal{M}_m)}{Pr(Z|\mathcal{M}_\ell)}}_{\text{Bayes factor}}$$

- usually the first term on the right hand side is equal to 1 (same prior probability for the two models);
- the choice between the models is based on the Bayes factor. Using some algebra (including the Lapalce approximation), we find

$$\log Pr(Z|\mathcal{M}_m) = \log Pr(Z|\hat{\theta}_m, \mathcal{M}_m) - \frac{d_m}{2} \log N + O(1).$$

### where:

- $\hat{\theta}_m$  is the maximum likelihood estimate of  $\theta_m$ ;
- $d_m$  is the number of free parameters in the model  $\mathcal{M}_m$ .

## The Bayesian Approach and BIC: motivations

#### Note:

- If the loss function is  $-2\log Pr(Z|\hat{\theta}_m,\mathcal{M}_m)$ , we find again the expression of BIC;
- selecting the model with smallest BIC corresponds to selecting the model with the highest posterior probability;
- in particular, note that,

$$\frac{e^{-\frac{1}{2}BIC_m}}{\sum_{\ell=1}^{M} e^{-\frac{1}{2}BIC_{\ell}}}$$

is the probability of selecting the model m (out of M models).

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### The Bayesian Approach and BIC: AIC versus BIC

For model selection, what to choose between AIC and BIC?

- there is no clear winner;
- BIC leads to a sparser model;
- AIC tends to be better for prediction;
- BIC is consistent  $(N \to \infty, \text{ Pr(select the true model}) = 1);$
- for finite sample sizes, BIC tends to select a model which is too sparse.

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